

Notice of References Cited		Application/Control No. 10/590,663	Applicant(s)/Patent Under Reexamination KOBAYASHI, HIDEO	
		Examiner Sylvia R. MacArthur	Art Unit 1716	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,332,055	02-2008	Orii et al.	156/345.17
*	B	US-6,793,769	09-2004	Kajino et al.	156/345.55
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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